

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/621,369 | Applicant(s)/Patent Under Reexamination OH, JANG GEUN | |
| | Examiner Stephen G. Sherman | Art Unit 2674 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------|----------------|
| | A | US-6,411,306 | 06-2002 | Miller et al. | 345/690 |
| | B | US-6,094,185 | 07-2000 | Shirriff, Kenneth W. | 345/102 |
| | C | US-2003/0043106 | 03-2003 | Woo, Jong Hyun | 345/101 |
| | D | US-6,559,826 | 05-2003 | Mendelson et al. | 345/102 |
| | E | US-2003/0035020 | 02-2003 | Menendez et al. | 347/37 |
| | F | US-5,394,167 | 02-1995 | Migny, Philippe | 345/690 |
| | G | US-5,933,130 | 08-1999 | Wagner, Roger | 345/690 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.